E ects of electron correlation on the photocurrent in quantum dot infrared photodetectors

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Abstract

The e ect of electron correlation on the photocurrent of self-assembled InA s/InG aAs quantum dot infrared photo-detector (QD IPs) is studied. It is found that C oulomb interaction and level mixing in the many-body open system lead to double peaks associated with the intra-band transitions involving two lowest levels of the quantum dot. Furthermore, the photocurrent is a nonlinear function of the steady-state carrier density and it displays a plateau due to C oulomb blockade.

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Recently, many e orts have been devoted to the understanding of transport properties in quantum dot photo-detectors (Q D IP s) [1,2]. The advantage of the Q D IP over quantum well photo-detectors (Q W IP s) is that light can be directly coupled to the electrons in the norm al incidence geometry due to the elect of Q D con nement in directions perpendicular to the grow th axis and the dark current is smaller for the same detection wave length considered [3]. O ther signing cantifications that are unique to Q D s include the C oulom b blockade elect [4].

Due to the bcalized nature of electrons in QDs, it is essential to take into account the e ects of Coulomb blockade in the analysis of photoresponse of QD Ps, which in general can be ignored in QW Ps. For the non-equilibrium system considered here, it is convenient to use the Keldysh G reen function to calculate the transport and optical properties while including the electron correlation. This technique has been used extensively in the study of nonlinear transport properties of quantum system s[5,6].

We solve the Anderson Ham iltonian of a two level system coupled with leads in the presence of an electrom agnetic radiation with frequency !. We adopt the approach given by Jouho et al[5,6] and extend it to the present case with asymmetric tunneling rates. We nd that the time averaged tunneling current is given by

$$hJ(t)_{j}i = \begin{pmatrix} R \\ j \end{pmatrix} \frac{ehN_{j}(t)i}{2} e^{\frac{L}{2}} \frac{d}{e} \begin{bmatrix} L \\ j \end{bmatrix} f_{L} = \begin{pmatrix} R \\ j \end{bmatrix} Im G_{j}^{r}(; !)$$
(1)

where $\ln_j(t)i$ is the electron occupation number at QD, $f_L = f(_L)$ and $f_R = f(_R)$ are the Ferm i distribution function of the left lead and right lead, respectively. The chemical potential di erence between these two leads is related to the applied bias (V_a) via $_L = _R = eV_a$. $_j^L$ and $_j^R$ denote the tunneling rates from the QD to the left and right leads, respectively, for electrons in level j. $G_j^r(;!)$ is the retarded G reen function for an electron in level jof the QD. The rst term in Eq. (1) for the excited state (j = 2) provides the photo-induced tunneling current which exists only when $_2^R \in _2^L$, a condition that can occur in a system with asymmetric potential.

Since the incident radiation considered in QDIP application is usually very weak, we can

ignore the renorm alization of the retarded G reen's function due to electron-photon interaction . Thus, we have (within the Hartree-Fock approximation)

$$G_{1}^{r}() = \frac{1}{E_{1} + i_{1}=2} + \frac{N_{1}}{E_{1} - U_{11} + i_{1}=2};$$

$$G_{2}^{r}() = \frac{1}{E_{2} + i_{2}=2} + \frac{N_{1}}{E_{2} - U_{12} + i_{2}=2};$$

where U_{11} denotes the C oulom b interaction between two electrons in level 1 and U_{12} denotes that for one electron in level 1 and the other in level 2. To calculate the steady-state electron occupation number for the QD, we solve the sem iconductor B loch equations for the two-level system coupled to leads and the electrom agnetic radiation.[6] W e obtain (for N₂ N₁)

$${}_{1}N_{1} = Im X \xrightarrow{Z} \frac{d}{d} [{}_{1}^{L}f_{L}() + {}_{1}^{R}f_{R}()]Im G_{1}^{r}();$$

$${}_{2}N_{2} = Im X \xrightarrow{Z} \frac{d}{d} [{}_{2}^{L}f_{L}() + {}_{2}^{R}f_{R}()]Im G_{2}^{r}();$$

and

X (!) = 2² (N₂ N₁)
$$f \frac{1 N_1}{!_r ! + i = 2} + \frac{N_1}{!_r + U_{12} U_{11} ! + i = 2} g;$$

where $!_r = E_2 = E_1$ is the resonant frequency, $_1 + _2$, and is the momentum matrix element for the inter-level optical transition.

Note that X (!) consists of two poles corresponding to optical transitions from initial states at E_1 and $(E_1 + U_{11})$ to nal states at E_2 and $(E_2 + U_{12})$, respectively. The two transitions have di erent relative strengths which depend on the averaged steady -state occupation number in the ground state, N_1 . The rst term corresponds to the inter-level transition of a single electron in the QD [which occurs with a relative probability (1 N₁)], while the second term corresponds to the inter-level transition of a second term corresponds to the inter-level transition of a second term corresponds to the inter-level transition of a second term corresponds to the inter-level transition of a second term corresponds to the inter-level transition of a second electron in the QD (which occurs with a relative probability N_1) under the in uence of the rst electron, which remains in the ground state at all times. In the latter case, the C oulomb repulsion between the two electrons give rise to an energy shift U_{12} U_{11} . The fact that we have a fractional

occupancy N_1 in a single quantum dot is attributed to the level mixing e ect (coupling of the QD level to the continuum states in the leads) in the many-body open system.

The theory is applied to a realistic self-assembled quantum dot (SAQD) device. We consider an InAs/InGaAs SAQD system with conical shape. The SAQD is embedded in a slab of InGaAs with nite width, W. The slab is then placed in contact with heavily doped InGaAs to form an n-i-n structure for infrared detection. W ithin the elective-mass model[3], the QD electron is described by the equation

$$[r \frac{1}{2m (;z)}r + V(;z) eFz](;;z) = E(;;z);$$

m (;z) is the position-dependent e ective mass, which takes on values of $m_G = 0.067 m_e$ (for G aA s) and $m_I = 0.024 m_e$ (for InA s). The potential V (;z) is equal to 0 in the InG aA s barrier region and V_0 inside the InA sQD region. The potential in the depletion layers (which separate the slab from the leads) are modelled by an electrostatic potential V_d (z)

$$V_{d}(z) = \begin{cases} \stackrel{\circ}{\gtrless} \frac{V_{1}}{D}(z + \frac{W}{2}) & \text{for} \quad (D + \frac{W}{2}) < z < \frac{W}{2} \\ \stackrel{?}{\end{Bmatrix}} \frac{V_{1}}{D}(z - \frac{W}{2}) & \text{for} \frac{W}{2} < z < D + \frac{W}{2} \end{cases}$$

For the purpose of constructing the approximate wave functions, we place the system in a large cylindrical conning box with length L and radius R (R must be much larger than the radius of the cone, r_c). We adopt R = 400A, D = 350 A, $V_1 = 0.205 eV$, and W = 300A for all calculations. We solve the eigen-functions of the elective-mass H amiltonian via the Ritz variational method. The wave functions are expanded in a set of basis functions which are chosen to be products of Bessel functions and sine waves

$$n_{m}$$
 (;;z) = $J_{1}(n) e^{il} sin [k_{m} (z + \frac{L}{2})];$

where $k_m = m = L$, m = 1,2,3... Throughout the paper, the origin of z is set at the middle of the con ming box. J₁ is the Bessel function of order 1 (l = 0;1;2;:::; etc.) and _nR is the n-th zero of J₁(x). 40 sine functions multiplied by 15 Bessel functions for each angular function (l = 0 or 1) are used to diagonalize the H am iltonian. Fig. 1 shows the energy levels of the con ned states with l = 0 (solid line) and 1 (dotted line) as functions of height h of the QD with base radius xed at $R_0 = 70$ A. The other material parameters used here are: wetting layer thickness d = 3 A, the conduction-band o set $V_0 = 0.4$ eV (this includes the e ect of hydrostatic strain due to the lattice m ismatch between InAs and $In_{0.2}Ga_{0.8}As$), and length of the con ming box L = 600 A. At least two bound states for each angular function (l = 0; or 1) are found. For infra-red detector application, we are seeking an intra-band transition (between the ground and material state) at an energy around 0.125 eV, which occurs at h = 50 A, for $R_0 = 70$ A. The tunneling rates can be calculated num erically via the stabilization method as described in Ref. 3.

W e only consider the zero tem perature and low bias case, where the chem ical potential at the left leads ($_{\rm L}$) is lower than E_2 , so that the average population in the exited state is sm all. Fig. 2 shows the photocurrent as a function of frequency for various applied voltages: solid line ($V_a = 0.11V$), dotted line ($V_a = 0.12V$), and dashed line ($V_a = 0.13V$). The parameters used to obtain Fig. 2 are $E_1 = 139m \text{ eV}$, $E_2 = 14m \text{ eV}$, $U_{11} = 10.4m \text{ eV}$, and U₂₁ = 72m eV, which are all calculated based on the e ective-m assmodel. The Fermi level in the source and drain region is assumed to E $_{\rm F}$ = 15m eV . The broadening of the energy level E_1 including all tunneling processes (dom instead by the acoustic-phonon assisted tunneling in this case) is assumed to be $_1 = 0.01 \text{ meV}$. The precise value of $_1$ is not important, since photocurrent is not sensitive to 1. For the excited state, the broadening parameter is given by $_2 = \frac{0}{2} + \frac{R}{2}$. $\frac{0}{2}$ is mainly due to radiative and non-radiative recombination from interacting with phonons and defects. The actual value depends on the sam ple quality and tem perature. Here, we assume $\frac{0}{2} = 1 \text{m eV}$. The other contribution due to the direct tunneling is calculated via the stabilization method as described in Ref. [3]. The values are found to be $\frac{R}{2} = 0.439 \text{m eV}$, 0.545 m eV, and 0.651 m eV for $V_a = 0.11$; 0.12, and 0.13V, respectively. The spectrum of photocurrent consists of two peaks centered at frequencies $! = E_2 \quad E_1$, and $! = E_2 \quad E_1 + U_{12} \quad U_{11}$. The relative strength of these peaks are determined by the average occupation number in the ground state (N_1) , which is bias-dependent. As

shown in the gure, the C oulomb interaction leads to a double-peak photocurrent spectrum with energy separation related to the intra-level and inter-level C oulomb energies (U_{11} and U_{12}).

For the QD IP characteristics, the photocurrent versus applied bias (J V curve) is also of interest[7-9]. Fig. 3 shows the photocurrent as a function of bias for frequencies at $!_r$ (dotted line) and $!_r + U_{12} = U_{11}$ (solid line). U sing Eq. (2) for the polarization, we can readily understand the behavior of photocurrent. The behavior of the photocurrent is determ ined by the prefactors (1 N₁)N₁ and N₁N₁ for the two poles at $! = !_r$ and $! = !_r + U_{12} = U_{11}$, respectively. At very low bias, N₁ is small; thus, the magnitude of the solid line is much weaker than that of the dotted line. As the applied bias increases, the solid line displays a plateau due to the elect of C oulom b blockade on N₁. When the applied bias overcom es the charging elect, N₁ = 0.5 and the solid line becomes alm ost identical to the dotted line.

In this study, we have used tunneling carriers as the source for photocurrent, in contrast to the captured carriers typically used in QW IPs. Due to the phonon bottleneck e ect[4], it is predicted that the capture rate of the electron by the QD will be low. This could reduce the perform ance of QD IPs which use captured carriers as a photocurrent source. U sing tunneling carriers as the photocurrent source will not have this draw back, and in this case we nd that the e ect of electron correlation leads to a double-peak spectrum and the photocurrent is a highly nonlinear function of the carrier density in the ground state N₁. Both of these e ects must be taken into account in the analysis of photocresponse of QD IPs.

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Fig. 1. Energies of the bound states of a conical InA s/ $In_{0.2}Ga_{0.8}AsQD$ as functions of height h of the QD with base radius xed at $R_0 = 70 A$. Solid lines: (l = 0). Dotted lines: (l = 1).

Fig. 2. Photocurrent as a function of frequency for di erent applied voltages: $V_a = 0.11V$ (solid line), $V_a = 0.12V$ (dotted line) and $V_a = 0.13V$ (dashed line).

Fig. 3. Photocurrent as a function of bias for incident frequencies at $! = E_2 = E_1$ (dotted line) and $! = E_2 = E_1 + U_{12} = U_{11}$ (solid line).

Figure Captions





